	Application No.	Applicant(s)	
Notice of Allowability	10/657,648 Examiner	SCHEPP ET AL. Art Unit	
-			
	Sun J. Lin	2825	
The MAILING DATE of this communication apper All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this app or other appropriate communication GHTS. This application is subject to	plication. If not included will be mailed in due course. THIS	
1. This communication is responsive to <u>Amendments & Remains</u>	arks filed on 05/02/2005.		
2. The allowed claim(s) is/are 27-53, renumbered (37 CFR 1.	<u>126)</u> .		
3. The drawings filed on <u>09/08/2003 and 05/02/2005</u> are acce	epted by the Examiner.		
 4. ☐ Acknowledgment is made of a claim for foreign priority una a) ☐ All b) ☐ Some* c) ☐ None of the: 1. ☐ Certified copies of the priority documents have 2. ☐ Certified copies of the priority documents have 3. ☐ Copies of the certified copies of the priority documents have International Bureau (PCT Rule 17.2(a)). * Certified copies not received: 	been received. been received in Application No		
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		complying with the requirements	
5. A SUBSTITUTE OATH OR DECLARATION must be submit INFORMAL PATENT APPLICATION (PTO-152) which give			
6. CORRECTED DRAWINGS (as "replacement sheets") mus	t be submitted.	•	
(a) 🔲 including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached			
1) hereto or 2) to Paper No./Mail Date			
(b) ☐ including changes required by the attached Examiner's Paper No./Mail Date	s Amendment / Comment or in the O	ffice action of	
Identifying indicia such as the application number (see 37 CFR 1. each sheet. Replacement sheet(s) should be labeled as such in t			
7. DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT I	sit of BIOLOGICAL MATERIAL n	nust be submitted. Note the	
Attachment(s) 1. Notice of References Cited (PTO-892) 2. Notice of Draftperson's Patent Drawing Review (PTO-948) 3. Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. ☐ Interview Summary Paper No./Mail Dat 8), 7. ☑ Examiner's Amendn	e .	

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Examiner's Amendment

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An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Applicants' attorney Paula D. Heyman gave authorization for this examiner's amendment on June 9, 2005. The application has been amended as follows:

Claim 27, line 3, before "network" delete -- remote-..

Claim 35, line 7, before "design" insert —the—.

Claim 35, line 12, before "design" insert —the—.

Claim 42, line 10, before "photomask" insert —the—.

Reasons for Allowance

Applicant's submitted exhibits attached with "Declaration" filed on 05/02/2005 is sufficient to overcome the examiner's cited reference (PhotoStore) under 37 CFR 1.131.

Therefore, Claims 27 – 53 are allowed over the prior art of record. An examiner's statement of reasons for allowance is given in the following.

As to Claims 27 – 53, the prior art does not teach or fairly suggest the following subject matters:

- A computer network for generating instructions for use by photomask manufacturing equipment comprises a computer accessible to a remote customer computer via a network connection to receive photomask specification data and design data and to store them in a database (i.e., same database), a command generator operable to generate fracturing instructions and control instructions based on the photomask specification data and a fracture engine that uses the fracturing instructions and the design data to generate fractured pattern data in combination with other limitations as recited in independent Claim 27;
- A method for generating instructions for use by photomask manufacturing equipment comprises <u>providing a network connection between a computer and a remote</u> <u>customer computer to receive photomask specification data and design data and to</u> <u>store them in a database (i.e., same database)</u>, <u>generating fracturing instructions and</u> <u>control instructions based on the photomask specification data</u> using a command

generator and generating fractured pattern data from the fracturing instructions and the design data using a fracture engine in combination with other limitations as recited in independent Claim 35;

- A method for automatically generating instruction for use by photomask manufacturing equipment comprises receiving photomask specification data in an electronic format from a customer computer and, in response to receiving the photomask specification data, automatically performing operations to generate fracture instructions, to generate equipment instructions from the fracture instructions and to electronically transmit the equipment instructions to the photomask manufacturing equipment in combination with other limitations as recited in independent Claim 42;
- A method for generating instruction for use by photomask manufacturing equipment comprises receiving photomask specification data in an electronic format from a customer computer and, in response to receiving the photomask specification data, automatically generating a job deck for photomask writing tools based on the photomask specification data in combination with other limitations as recited in independent Claim 53.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance".

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Sun J. Lin whose telephone number is (571) 272 – 1899. The examiner can normally be reached on Monday to Friday from 9:30am to 6:30pm.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-1782.

Sun J. Lin Patent Examiner Art Unit 2825 June 9, 2005

Network-Based Photomask Data Entry Interface and Instruction Generator for Manufacturing Photomasks Inventors: X. Long Dai, et al. Serial No. 10/661,187 Filing Date: 09/12/2003 Attorney Docket 068062.0166 REPLACEMENT Sheet 1 of 1

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Reviewed OK Jest 6-8-05

51.

50 Info Feedback Mask Order Account Main Menu Quote/Account Help Logout Patterns | Placements Fractures Business Submit Layers Instructions General **TestCompany** View summary In Progress Please complete the information for each distinct pattern, and press the "Save and Forward" button to progress to Pattern Placement. If the number of patterns or layer information is wrong, please return to the General Info Screen and correct the number of distinct patterns, then return to this screen. -Save And Back Save And Stay Save And Forward -Patterns 1 - 1 of 1 Layers 1 - 1 of 1 Pattern Pattern Name: Fracture Required? Number of Address Final CD **Tolerance** Digitized Layer Placements Units $Size(\mu)$ Digitized? Data Tone Out (μ) (μ) Pattern application **(1)** (Q)(b)-Save And Back Save And Stay Save And Forward --P =Optional for order (V)=Required for this =Required for submit, optional for this screen screen

FIG. 5

Network-Based Photomask Data Entry Interface and Instruction Generator for Manufacturing Photomasks Inventors: X. Long Dai, et al. Serial No. 10/661,187 Filing Date: 09/12/2003 Attorney Docket 068062.0166 ANNOTATED Sheet I of I

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50- Element 50 Added

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	Main Menu Get a Quote/Account Account Mask Order Help Logout Instructions General Layers Patterns Placements Fractures Business Submit		
	TestCompany View summary In Progress		
Please complete the information for each distinct pattern, and press the "Save and Forward" button to progress to Pattern Placement.			
	If the number of patterns or layer information is wrong, please return to the <u>General Info Screen</u> and correct the number of distinct patterns, then return to this screen.		
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FIG. 5

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"Patent" changed to "Pattern"